



Notice of References Cited

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Application/Control No.	Applicant(s)/Pat	ent Under
09/103,398	Reexamination SENDA, AKIRA	
Examiner	Art Unit	
Jason T. Whipkey	2612	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,157,431	18-1992	Mabuchi et al.	396/80
*	В	US-5,274,414	12-1993	Taniguchi et al.	396/79
*	С	US-5,420,721	05-1995	Kanno et al.	396/133
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.